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Specification

(Reference)

Title: FIXED THIN FILM CHIP RESISTORS;

RECTANGULAR TYPE

Style: RNC06, 20, 32

RoHS COMPLIANCE ITEM
Halogen and Antimony Free

Product specification contained in this specification are subject to change at any time without notice If you have any questions or a Purchasing Specification for any quality Agreement is necessary, please contact our sales staff.



Issue Dept.: Research & Development Department Hokkaido Research Center

Drawing No: RNC-K-HTS-0001

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Title: FIXED THIN FILM CHIP RESISTORS; RECTANGULAR TYPE

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1. Scope

1.1 This specification covers the detail requirements for fixed thin film chip resistors; rectangular type & precision, style of RNC06, 20, 32.

1.2 Applicable documents

JIS C 5201-1: 1998, JIS C 5201-8: 1998, JIS C 5201-8-1: 1998

IEC60115-1: 1999, IEC60115-8: 1989 Amendment 1: 1992, IEC60115-8-1: 1989

EIAJ RC-2133B-2002

2. Classification

Type designation shall be the following form.

(Example)

		0			
RNC	32	Е	1002	В	В
1	2	3	4	5	6
Style					

- 1 Fixed thin film chip resistors; rectangular type
- 2 Size
- 3 Temperature coefficient of resistance

Е	±25×10 ⁶ / °C
C	±50×10 ⁶ / °C

- 4 Rated resistance Example; $1002 \rightarrow 10 \text{k}\Omega$
- 5 Tolerance on rated resistance
- 6 Packaging form

3. Rating

3.1 The ratings shall be in accordance with Table-1.

Table-1

Style	Rated dissipation (W)	Temperature coefficient of resistance (10-6/°C)	Rated resistance range(Ω)	Preferred number series for resistors	Tolerance on rated resistance
	0.03	E: ±25	100~10k		B(±0.1%)
RNC06	0.05	E: ±25	27~4.99k	E24,96	D(±0.5%)
		C: ±50	5.1k~10k		
RNC20	0.1		100~130k		B(±0.1%)
RINCZU	0.1	E: +25	10~130k		C(±0.25%), D(±0.5%)
RNC32	0.125	⊑; ±23	100~180k		B(±0.1%)
RINCSZ	0.125		10~180k		C(±0.25%), D(±0.5%)

Style	Limiting element voltage (V)	Isolation Voltage (V)	Category temperature range(°C)
RNC06	15	50	
RNC20	100	100	<i>–</i> 55~+155
RNC32	200	100	

3.2 Climatic category

55/125/56 Lower category temperature –55 °C

Upper category temperature +155 °C

Duration of the damp heat, steady state test 56days

3.3 Stability class

1% Limits for change of resistance:

- for long - term tests $\pm (1.0\% + 0.05\Omega)$ - for short - term tests $\pm (0.25\% + 0.05\Omega)$ RNC06, 20, 32 Page: 2/12

3.4 Derating

The derated values of dissipation at temperature in excess of 70°C shall be as indicated by the following curve.

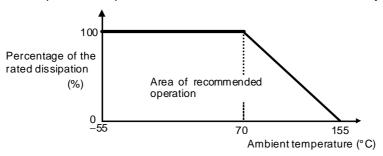


Figure-1 Derating curve

3.5 Rated voltage

d.c.or a.c.r.m.s.voltage calculated from the square root of the product of the rated resistance and the rated dissipation.

$$E = \sqrt{P \cdot R}$$

E: Rated voltage (V)

P: Rated dissipation (W)

R: Rated resistance (Ω)

Limiting element voltage can only be applied to resistors when the resistance value is equal to or higher than the critical resistance value.

At high value of resistance, the rated voltage may not be applicable.

4. Packaging form

The standard packaging form shall be in accordance with Table-2.

Table-2

Symbol	Packaging form		Standard packaging quantity / units	Application
В	Bulk (loose package)		1,000 pcs.	RNC06, 20, 32
PA	Press pocket taping (paper taping)	8mm width, 2mm pitches	15,000 pcs.	RNC06
TP	Paper taping	8mm width, 4mm pitches	5,000 pcs.	RNC20, 32

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5. Dimensions

5.1 The resistor shall be of the design and physical dimensions in accordance with Figure-2 and Table-3.

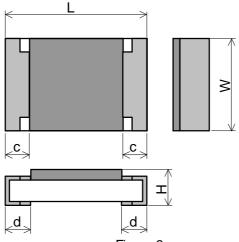


Figure-2

Table-3					Unit: mm
Style	L	W	Н	С	d
RNC06	0.6±0.03	0.3±0.03	0.23±0.03	0.1±0.05	0.15±0.05
RNC20	2.0±0.15	1.25 ^{+0.10} _{-0.05}	0.6±0.1	0.4±0.2	$0.3^{+0.2}_{-0.1}$
RNC32	3.1±0.1	1.55 ^{+0.10} _{-0.05}	0.6±0.1	0.45±0.20	$0.3^{+0.2}_{-0.1}$

5.2 Net weight (Reference)

Style	Net weight(mg)			
RNC06	0.16			
RNC20	5			
RNC32	9			

6. Marking

The Rated resistance shall be marked in 3 digits (E24) or 4 digits (E96) and marked on over coat side.

The Rated resistance of RNC06 should not be marked.

(Example)

"123"
$$\rightarrow$$
 12 \times 10³ [Ω] \rightarrow 12 [$k\Omega$]

"3R3"
$$ightarrow$$
 3.3 [Ω]

"5623" \rightarrow 562 \times 10³ [Ω] \rightarrow 562 [$k\Omega$]

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7. Performance

7.1 The standard condition for tests shall be in accordance with Sub-clause 4.2, JIS C 5201–1: 1998.

7.2 The performance shall be satisfied in Table-4.

Table-4(1)

No.	Test items	Condition of test (JIS C 5201–1)	Performance requirements
1	Visual examination	Sub-clause 4.4.1	As in 4.4.1
'	Visual Callin audi	Checked by visual examination.	The marking shall be legible, as
		oned by violational materia	checked by visual examination.
2	Dimension	Sub-clause 4.4.2	As specified in Table-3 of this
			specification.
	Resistance	Sub-clause 4.5	As in 4.5.2
			The resistance value shall
			correspond with the rated resistance
			taking into account the specified
3	Voltage proof	Sub-clause 4.7	tolerance. No breakdown or flash over
J	Vollage proof	Method: 4.6.1.4(See Figure–5)	NO DIEARGOWITOI IIASITOVEI
		Test voltage: Alternating voltage with a peak	
		value of 1.42 times the insulation voltage.	
		Duration: 60 s ± 5 s	
		Insulation resistance	$R \ge 1 G \Omega$
		Test voltage: Insulation voltage	
		Duration: 1 min.	
4	Solderability	Sub-clause 4.17	As in 4.17.4.5
		Without ageing	The terminations shall be covered
		Flux: The resistors shall be immersed in a	with a smooth and bright solder coating.
		non–activated soldering flux for 2s. Bath temperature: $235 ^{\circ}C \pm 5 ^{\circ}C$	Coauling.
		Immersion time: 2 s ± 0.5 s	
5	Mounting	Sub-clause 4.31	
J	TVICALIAN IS	Substrate material: Epoxide woven glass	
		Test substrate: Figure-3	
	Overload	Sub-clause 4.13	
	(in the mounted state)	The applied voltage shall be 2.5 times the	
		rated voltage or twice the limiting element	
		voltage, whichever is the less severe.	
		Duration: 2 s	No visible domage
		Visual examination	No visible damage $\Delta R \le \pm (0.25\% + 0.05\Omega)$
	Solvent resistance of the	Resistance	Legible marking
	marking	Sub-clause 4.30	Logible maining
	9	Solvent: 2-propanol Solvent temperature: 23 °C ± 5 °C	
		Method 1	
		Rubbing material: cotton wool	
		Without recovery	

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Table-4(2)

No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
6	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure-4	
	Bound strength of the end face	Sub-clause 4.33	
	plating	Bent value: 3 mm	
		Resistance	$\Delta R \le \pm (0.25\% + 0.05\Omega)$
	Final measurements	Sub-clause 4.33.6	
		Visual examination	No visible damage
7	Resistance to soldering heat	Sub-clause 4.18	
		Solder temperature: 260 °C ± 5 °C	
		Immersion time: 10 s ± 0.5 s	
		Visual examination	As in 4.18.3.4
			No sign of damage such as cracks.
		Resistance	$\Delta R \le \pm (0.25\% + 0.05\Omega)$
	Component solvent resistance	Sub-clause 4.29	
		Solvent: 2-propanol	
		Solvent temperature: 23 °C ± 5 °C	
		Method 2	
		Recovery: 48 h	
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (0.25\% + 0.05\Omega)$
8	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Adhesion	Sub-clause 4.32	
		Force: 5 N (RNC06: 3N)	
		Duration: 10 s ± 1 s	Nie Sellie de como
	Daniel about to to to the	Visual examination	No visible damage
	Rapid change temperature	Sub-clause 4.19	
		Lower category temperature: –55 °C	
		Upper category temperature: +155 °C	
		Duration of exposure at each temperature: 30	
		min.	
		Number of cycles: 5 cycles.	No visible damage
		Visual examination	$\Delta R \le \pm (0.25\% + 0.05\Omega)$
L		Resistance	<u> </u>

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Table-4(3)

No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
9	Climatic sequence	Sub-clause 4.23	
	-Dry heat	Sub-clause 4.23.2	
	-	Test temperature: + 155 °C	
		Duration: 16 h	
	–Damp heat, cycle	Sub-clause 4.23.3	
	(12+12hour cycle)	Test method: 2	
	First cycle	Test temperature: 55 °C	
		[Severity(2)]	
	-Cold	Sub-clause 4.23.4	
		Test temperature –55 °C	
		Duration: 2h	
	–Damp heat, cycle	Sub-clause 4.23.6	
	(12+12hour cycle)	Test method: 2	
	Remaining cycle	Test temperature: 55 °C	
		[Severity (2)]	
		Number of cycles: 5 cycles	
	–D.C. load	Sub-clause 4.23.7	
		The applied voltage shall be the rated voltage	
		or the limiting element voltage whichever is	
		the smaller.	
		Duration: 1 min.	No visible damage
		Visual examination	$\Delta R \le \pm (1\% + 0.05\Omega)$
40	1.0	Resistance	Zi (= (1 / 0 / 0 i 0 0 2 2)
10	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
	Find: wor on at 70 °C	Test substrate: Figure–3	
	Endurance at 70 °C	Sub-clause 4.25.1	
		Ambient temperature: 70 °C ± 2 °C	
		Duration: 1000 h	
		The voltage shall be applied in cycles of 1.5 h	
		on and 0.5 h.	
		The applied voltage shall be the rated voltage	
		or the limiting element voltage whichever is the smaller.	
		Examination at 48 h, 500 h and	
		1000 h:	
		Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$

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Table-4(4)

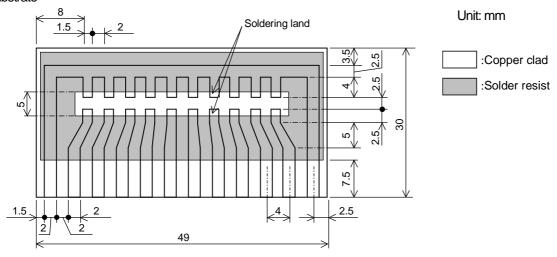
No	Test items	Condition of test (JIS C 5201–1)	Performance requirements
11	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Variation of resistance with	Sub-clause 4.8	As in Table–1
	temperature	+20 °C / +125°C	
12	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide woven glass	
		Test substrate: Figure–3	
	Damp heat, steady state	Sub-clause 4.24	
		Ambient temperature: 40 °C ± 2 °C	
		Relative humidity: 93^{+2}_{-3} %	
		a) 1st group: without voltage applied.	
		b) 2nd group: The d.c.voltage shall be applied	
		continuously.	
		The voltage shall be accordance with	
		Sub-clause 4.24.2.1 b). without polarizing	
		voltage [4.24.2.1, c)] Visual examination	No visible damage
		Visual examination	Legible marking
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$
13	Dimensions (detail)	Sub-clause 4.4.3	As in Table–3
	NA		
	Mounting	Sub-clause 4.31	
		Substrate material: Epoxide	
		woven glass	
	Endurance at upper	Test substrate: Figure–3	
	category temperature	Sub-clause 4.25.3	
	Category temperature	Ambient temperature: 155 °C ± 2 °C	
		Duration: 1000 h	
		Examination at 48 h, 500 h and 1000 h: Visual examination	No visible damage
		Resistance	$\Delta R \le \pm (1\% + 0.05\Omega)$
		1 / COIOIGI IUC	

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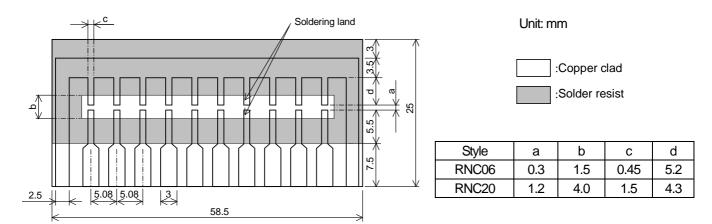
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8. Test substrate



RNC32 TEST SUBSTRATE



RNC06, 20 TEST SUBSTRATE

Figure_3

Remark 1). Material: Epoxide woven glass

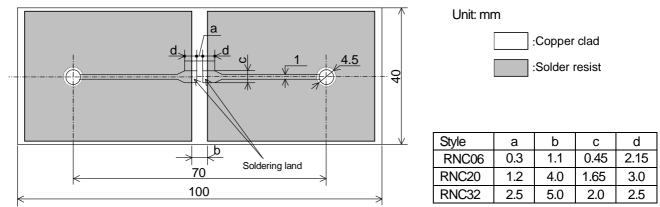
Thickness: 1.6mm Thickness of copper clad: 0.035mm

2). In the case of connection by connector, the connecting terminals are gold plated. However, the plating is not necessary when the connection is made by soldering.

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RNC BOUND STRENGTH OF THE END FACE PLATING TEST TEST SUBSTRATE

Figure-4

Remark 1). Material: Epoxide woven glass

Thickness: 1.6mm Thickness of copper clad: 0.035mm

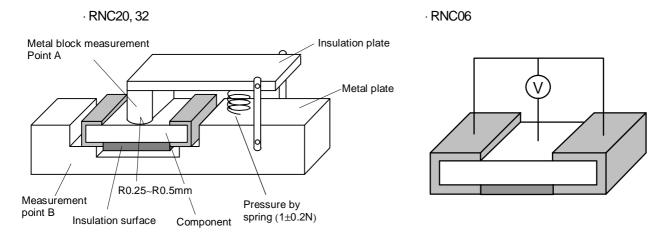


Figure-5

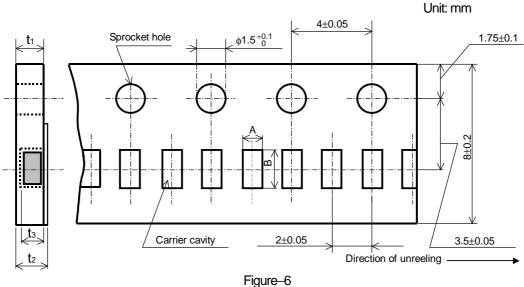
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9. Taping

- 9.1 Applicable documents JIS C 0806-3: 1999, EIAJ ET-7103: 2004, EIAJ ET-7200B: 2003
- 9.2 Taping dimensions
- 9.2.1 Press pocket taping (Paper taping, 8mm width, 2mm pitches)

Taping dimensions shall be in accordance with Figure-6 and Table-5.



Figure–6
Table–5
Unit: mm

Style A B t t t t t t t t 3

RNC06 0.37±0.05 0.67±0.05 0.42±0.03 0.45±0.05 0.27±0.02

9.2.2 Paper taping (8mm width, 4mm pitches)

Taping dimensions shall be in accordance with Figure-7 and Table-6.

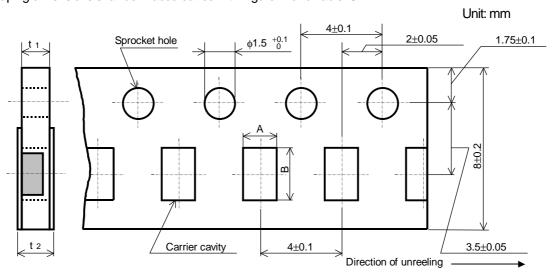


Figure-7
Table-6
Unit: mm

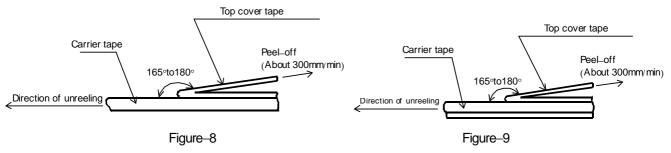
Style A B t₁ t₂

RNC20 1.65 ± 0.15 2.5 ± 0.2
RNC32 2.00 ± 0.15 3.6 ± 0.2
Unit: mm

1.0max.

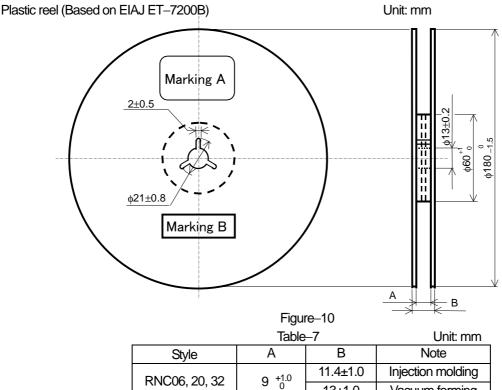
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- 1). The cover tapes shall not cover the sprocket holes.
- 2). Tapes in adjacent layers shall not stick together in the packing.
- 3). Components shall not stick to the carrier tape or to the cover tape.
- 4). Pitch tolerance over any 10 pitches ±0.2mm.
- 5). The peel strength of the top cover tape shall be with in 0.1N to 0.5N on the test method as shown in the following RNC06: Figure-8, RNC20, 32: Figure-9.
- 6). When the tape is bent with the minimum radius for 25 mm, the tape shall not be damaged and the components shall maintain their position and orientation in the tape.
- 7). In no case shall there be two or more consecutive components missing. The maximum number of missing components shall be one or 0.1%, whichever is greater.
- 8). The resistors shall be faced to upward at the over coating side in the carrier cavity.



9.3 Reel dimension

Reel dimensions shall be in accordance with the following Figure-10 and Table-7.



Note: Marking label shall be marked on a place of Marking A or two place of marking A and B.

13±1.0

Vacuum forming

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9.4 Leader and trailer tape.

(Example)

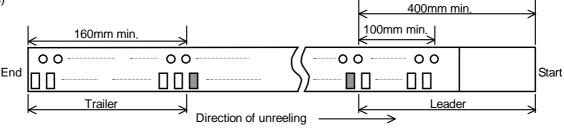


Figure-11

10. Marking on package

The label of a minimum package shall be legibly marked with follows.

10.1 Marking A

(1) Classification

(Style, Temperature coefficient of resistance, Rated resistance, Tolerance on rated resistance, Packaging form)

(2) Quantity (3) Lot number (4) Manufacturer's name or trade mark (5) Others 10.2 Marking B (KAMAYA Control label)